Search	Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
09/840,861	DUPRET ET AL.	DUPRET ET AL.	
Examiner	Art Unit	Art Unit	
Young J. Kim	1637	1637	

	SEARCHED		
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	INTERFERENCE SEARCHED			
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SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
Patent Databases (USPT, USPGP, EPO, JPO, DERWENT, IBM-TDB)	7/27/2005	YJK
See enclosed search strategy	7/27/2005	YJK
		